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FDS6679AZ P-Channel PowerTrench[®] MOSFET -30V, -13A, $9m\Omega$

General Description

This P-Channel MOSFET is producted using ON Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance.

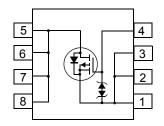
This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.



Features

- Max $r_{DS(on)}$ = 9.3m Ω at V_{GS} = -10V, I_D = -13A
- Max $r_{DS(on)}$ = 14.8m Ω at V_{GS} = -4.5V, I_D = -11A
- Extended V_{GS} range (-25V) for battery applications
- HBM ESD protection level of 6kV typical (note 3)
- High performance trench technology for extremely low 「FDS(on)
- High power and current handing capability
- RoHS Compliant





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

| Symbol | Parameter | Parameter Ratings | | | | |
|-----------------------------------|--|-------------------|-------------------------|----|-----|---|
| V_{DS} | Drain to Source Voltage | | Drain to Source Voltage | | -30 | V |
| V_{GS} | Gate to Source Voltage | | ±25 | V | | |
| | Drain Current -Continuous | (Note 1a) | -13 | ۸ | | |
| ID | -Pulsed | | -65 | Α | | |
| | Power Dissipation for Single Operation | (Note 1a) | 2.5 | | | |
| P_{D} | | (Note 1b) | 1.2 | W | | |
| | | (Note 1c) | 1.0 | | | |
| T _J , T _{STG} | Operating and Storage Temperature | | -55 to +150 | °C | | |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance , Junction to Ambient (Note 1a) | 50 | °C/W |
|-----------------|--|----|------|
| $R_{\theta JC}$ | Thermal Resistance , Junction to Case (Note 1) | 25 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape Width | Quantity |
|----------------|-----------|-----------|------------|------------|
| FDS6679AZ | FDS6679AZ | 13" | 12mm | 2500 units |

Electrical Characteristics T_J = 25°C unless otherwise noted

Parameter

| Off Characteristics | | | | | | | |
|--|---|---|-----|-----|-----|-------|--|
| B _{VDSS} | Drain to Source Breakdown Voltage | $I_D = -250 \mu A$, $V_{GS} = 0 V$ | -30 | | | V | |
| $\frac{\Delta B_{VDSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | I_D = -250 μ A, referenced to 25°C | | -20 | | mV/°C | |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = -24V, V _{GS} =0V | | | -1 | μΑ | |
| I _{GSS} | Gate to Source Leakage Current | V_{GS} = ±25V, V_{DS} =0V | | | ±10 | μΑ | |

Test Conditions

Min

Тур

Max

Units

On Characteristics (Note 2)

Symbol

| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = -250 \mu A$ | -1 | -1.9 | -3 | V |
|--|---|--|----|------|------|-------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | I_D = -250 μ A, referenced to 25°C | | 6.5 | | mV/°C |
| r _{DS(on)} | Drain to Source On Resistance | $V_{GS} = -10V, I_D = -13A$ | | 7.7 | 9.3 | mΩ |
| | | $V_{GS} = -4.5V, I_D = -11A$ | | 11.8 | 14.8 | |
| | | $V_{GS} = -10V, I_D = -13A,$ $T_J = 125^{\circ}C$ | | 10.7 | 13.4 | |
| g _{FS} | Forward Transconductance | $V_{DS} = -5V, I_{D} = -13A$ | | 55 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | \\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ | 2890 | 3845 | pF |
|------------------|------------------------------|---|------|------|----|
| C _{oss} | Output Capacitance | V _{DS} = -15V, V _{GS} = 0V, f = 1MHz | 500 | 665 | pF |
| C _{rss} | Reverse Transfer Capacitance | t = 1MHZ | 495 | 745 | pF |

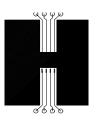
Switching Characteristics (Note 2)

| t _{d(on)} | Turn-On Delay Time | | 13 | 24 | ns |
|---------------------|----------------------------|---|-----|-----|----|
| t _r | Rise Time | $V_{DD} = -15V, I_{D} = -1A$ $V_{GS} = -10V, R_{GS} = 6\Omega$ | 15 | 27 | ns |
| t _{d(off)} | Turn-Off Delay Time | V _{GS} = -10V, K _{GS} = 012 | 210 | 336 | ns |
| t _f | Fall Time | | 92 | 148 | ns |
| Qg | Total Gate Charge | $V_{DS} = -15V, V_{GS} = -10V,$ $I_{D} = -13A$ | 68 | 96 | nC |
| Q_g | Total Gate Charge | V 45V.V 5V | 38 | 54 | nC |
| Q_{gs} | Gate to Source Gate Charge | $V_{DS} = -15V, V_{GS} = -5V,$ $I_{D} = -13A$ | 10 | | nC |
| Q_{gd} | Gate to Drain Charge | | 17 | | nC |

Drain-Source Diode Characteristic

| V_{SD} | Source to Drain Diode Forward Voltage | $V_{GS} = 0V, I_{S} = -2.1A$ | -0.7 | -1.2 | V |
|-----------------|---------------------------------------|--------------------------------------|------|------|----|
| t _{rr} | Reverse Recovery Time | $I_F = -13A$, $di/dt = 100A/\mu s$ | | 40 | ns |
| Q _{rr} | Reverse Recovery Charge | $I_F = -13A$, di/dt = 100A/ μ s | | -31 | nC |

13 R_{B,IA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{B,C} is guaranteed by design while R_{B,CA} is determined by the user's board design.



a) 50°C/W when mounted on a 1 in² pad of 2 oz copper



b)105°C/W when mounted on a .04 in² pad of 2 oz copper



c) 125°C/W when mounted on a minimun pad

Scale 1: 1 on letter size paper

- 2: Pulse Test:Pulse Width <300 μ s, Duty Cycle <2.0%
- 3: The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25°C unless otherwise noted

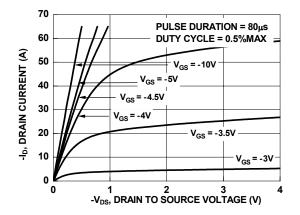


Figure 1. On Region Characteristics

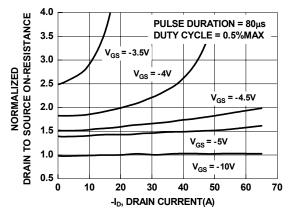


Figure 2. Normalized On-Resistance vs Drain **Current and Gate Voltage**

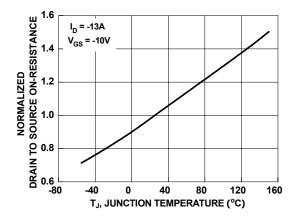


Figure 3. Normalized On Resistance vs Junction **Temperature**

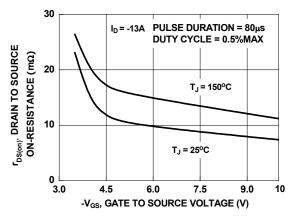


Figure 4. On-Resistance vs Gate to Source Voltage

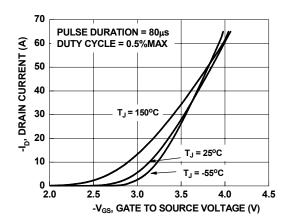


Figure 5. Transfer Characteristics

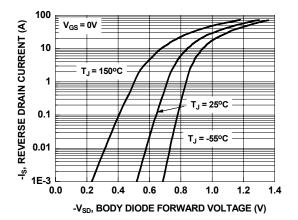


Figure 6. Source to Drain Diode Forward Voltage vs Source Current



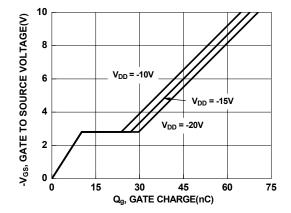


Figure 7. Gate Charge Characteristics

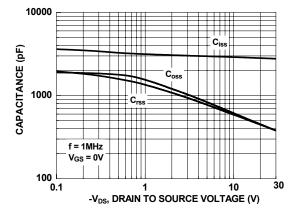


Figure 8. Capacitance vs Drain to Source Voltage

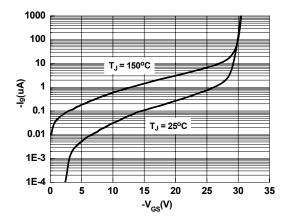


Figure 9. $I_g vs V_{GS}$

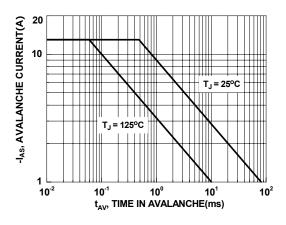


Figure 10. Unclamped Inductive Switching Capability

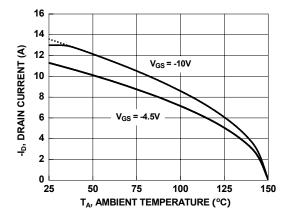


Figure 11. Maximum Continuous Drain Current vs
Ambient Temperature

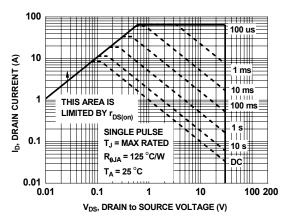


Figure 12. Forward Bias Safe Operating Area



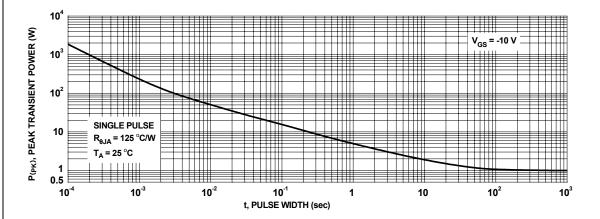


Figure 13. Single Pulse Maximum Power Dissipation

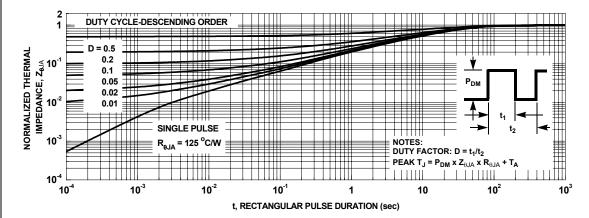


Figure 14. Junction-to-Ambient Transient Thermal Response Curve

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